IRLD014

Vishay Siliconix



HVMDIP

PRODUCT SUMMARY

V_{DS} (V)

R_{DS(on)} (Ω)

Q_{qs} (nC)

Q_{ad} (nC)

Qg (Max.) (nC)

Configuration

Power MOSFET

s

N-Channel MOSFET

0.20

60

8.4

2.6

6.4

Single

 $V_{GS} = 5 V$

FEATURES

- Dynamic dV/dt rating
- For automatic insertion
- End stackable
- Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 175 °C operating temperature
- Fast switching
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertiable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lead (Pb)-free	IRLD014PbF

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	60	V	
Gate-source voltage			V _{GS}	± 10		
Continuous drain current	V _{GS} at 5.0 V	T _A = 25 °C	- I _D	1.7		
		T _A = 100 °C		1.2	А	
Pulsed drain current ^a			I _{DM}	14	1	
Linear derating factor				0.0083	W/°C	
Single pulse avalanche energy ^b			E _{AS}	490	mJ	
Maximum power dissipation	T _A = 25 °C		PD	1.3	W	
Peak diode recovery dV/dt ^c		dV/dt	4.5	V/ns		
Operating junction and storage temperature range		T _J , T _{stg}	- 55 to + 175			
Soldering recommendations (peak temperature)	For 10 s			300 ^d	- °C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. V_{DD} = 25 V, starting T_J = 25 °C, L = 197 mH, R_g = 25 Ω , I_{AS} = 1.7 A (see fig. 12)

c. $I_{SD} \le 10$ A, dI/dt ≤ 90 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C

d. 1.6 mm from case

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static				•			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 1 \text{ mA}$		-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$		1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 10 \text{ V}$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$		-	-	25	μA
		V _{DS} = 48 V	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$		-	250	
Drain-Source On-State Resistance	D	$V_{GS} = 5.0 \text{ V}$	I _D = 1.0 A ^b	-	-	0.20	Ω
	R _{DS(on)}	$V_{GS} = 4.0 \text{ V}$	I _D = 0.85 A ^b	-	-	0.28	
Forward Transconductance	9 _{fs}	$V_{DS} = 25 \text{ V}, I_D = 1.0 \text{ A}^{b}$		1.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V$ $V_{DS} = 25 V$ f = 1.0 MHz, see fig. 5		-	400	-	pF
Output Capacitance	Coss			-	170	-	
Reverse Transfer Capacitance	C _{rss}			-	42	-	
Total Gate Charge	Qg		I _D = 10 A, V _{DS} = 48 V see fig. 6 and 13 ^b	-	-	8.4	nC
Gate-Source Charge	Q_gs	$V_{GS} = 5.0 \text{ V}$		-	-	2.6	
Gate-Drain Charge	Q _{gd}		see lig. 0 and 13		-	6.4	1
Turn-On Delay Time	t _{d(on)}				9.3	-	- ns
Rise Time	t _r	V_{DD} = 30 V, I_D = 10 A R_g = 12 Ω , R_D = 2.8 Ω , see fig. 10 ^b		-	110	-	
Turn-Off Delay Time	t _{d(off)}			-	17	-	
Fall Time	t _f			-	26	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	- nH
Internal Source Inductance	L _S			-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.7	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	14	
Body Diode Voltage	V_{SD}	$T_{\rm J} = 25~^{\circ}{\rm C}, I_{\rm S} = 1.7~{\rm A}, V_{\rm GS} = 0~{\rm V}^{\rm b}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	$T_{\rm J} = 25 ^{\circ}\text{C}$, $I_{\rm F} = 10 \text{A}$, dl/dt = 100 A/µs ^b		-	93	130	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.34	0.65	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	I-on is dor	ninated b	$v L_s$ and	Ln)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

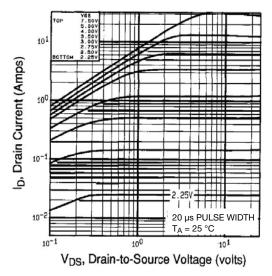


Fig. 1 - Typical Output Characteristics, $T_A = 25 \ ^\circ C$

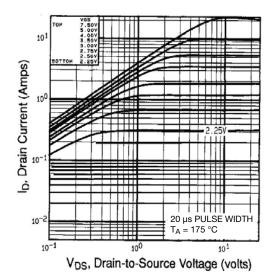


Fig. 2 - Typical Output Characteristics, $T_A = 175 \ ^{\circ}C$

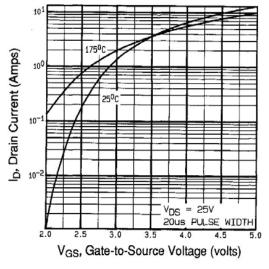


Fig. 3 - Typical Transfer Characteristics

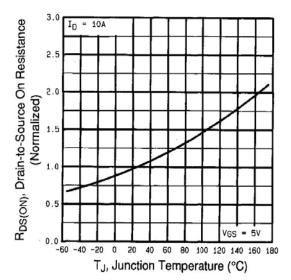


Fig. 4 - Normalized On-Resistance vs. Temperature

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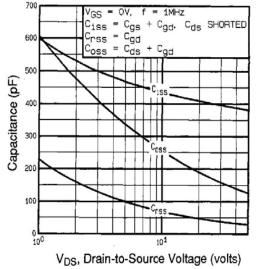


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

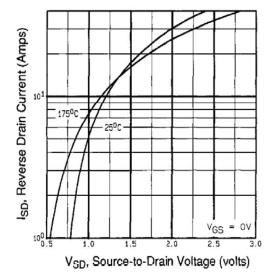


Fig. 7 - Typical Source-Drain Diode Forward Voltage

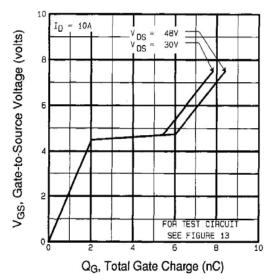
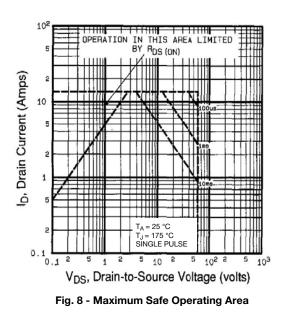


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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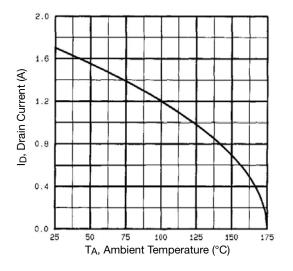


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

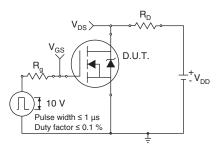


Fig. 10a - Switching Time Test Circuit

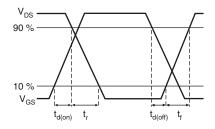


Fig. 10b - Switching Time Waveforms

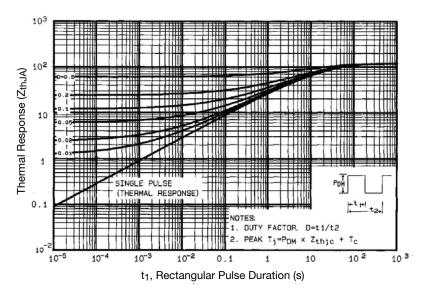


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



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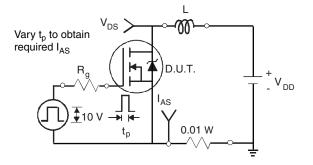


Fig. 12a - Unclamped Inductive Test Circuit

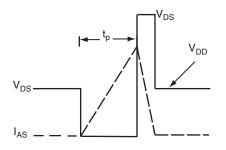


Fig. 12b - Unclamped Inductive Waveforms

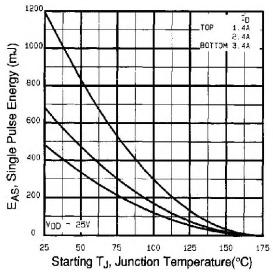
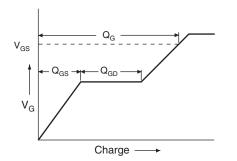
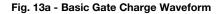


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





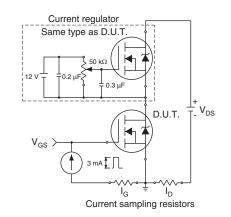


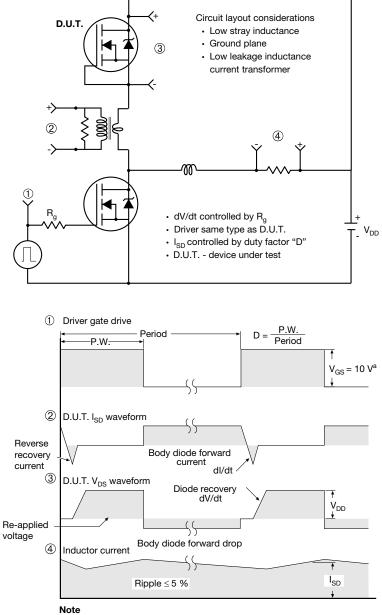
Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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Revision: 01-Jan-2024